

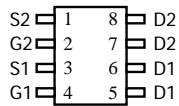
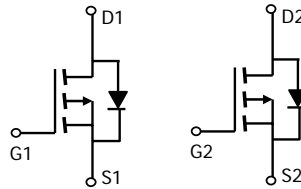
**AO4801**
**Dual P-Channel Enhancement Mode Field Effect Transistor**

**General Description**

The AO4801 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. It may be used in a common drain arrangement to form a bidirectional blocking switch. *Standard Product AO4801 is Pb-free (meets ROHS & Sony 259 specifications). AO4801L is a Green Product ordering option. AO4801 and AO4801L are electrically identical.*

**Features**

$V_{DS}$  (V) = -30V  
 $I_D$  = -5 A ( $V_{GS}$  = -10V)  
 $R_{DS(ON)} < 49m\Omega$  ( $V_{GS}$  = -10V)  
 $R_{DS(ON)} < 64m\Omega$  ( $V_{GS}$  = -4.5V)  
 $R_{DS(ON)} < 120m\Omega$  ( $V_{GS}$  = -2.5V)


**SOIC-8**

**Absolute Maximum Ratings  $T_A=25^\circ\text{C}$  unless otherwise noted**

| Parameter                              | Symbol                 | Maximum                | Units            |
|--|------------------------|------------------------|------------------|
| Drain-Source Voltage                   | $V_{DS}$               | -30                    | V                |
| Gate-Source Voltage                    | $V_{GS}$               | $\pm 12$               | V                |
| Continuous Drain Current <sup>A</sup>  | $I_D$                  | -5                     | A                |
|  |                        | $T_A=25^\circ\text{C}$ |                  |
|  | $T_A=70^\circ\text{C}$ | -4.2                   |                  |
| Pulsed Drain Current <sup>B</sup>      | $I_{DM}$               | -30                    |                  |
| Power Dissipation <sup>A</sup>         | $P_D$                  | 2                      | W                |
|  |                        | $T_A=25^\circ\text{C}$ |                  |
|  | $T_A=70^\circ\text{C}$ | 1.44                   |                  |
| Junction and Storage Temperature Range | $T_J, T_{STG}$         | -55 to 150             | $^\circ\text{C}$ |

**Thermal Characteristics**

| Parameter                                | Symbol          | Typ                 | Max  | Units              |
|--|-----------------|---------------------|------|--------------------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 48                  | 62.5 | $^\circ\text{C/W}$ |
|  |                 | $t \leq 10\text{s}$ |      |                    |
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{\theta JA}$ | 74                  | 110  | $^\circ\text{C/W}$ |
|  |                 | Steady-State        |      |                    |
| Maximum Junction-to-Lead <sup>C</sup>    | $R_{\theta JL}$ | 35                  | 40   | $^\circ\text{C/W}$ |

Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)

| Symbol                      | Parameter                             | Conditions  | Min  | Typ   | Max       | Units            |
|-----------------------------|---------------------------------------|---|------|-------|-----------|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |   |      |       |           |                  |
| $BV_{DSS}$                  | Drain-Source Breakdown Voltage        | $I_D=-250\mu\text{A}$ , $V_{GS}=0\text{V}$                          | -30  |       |           | V                |
| $I_{DSS}$                   | Zero Gate Voltage Drain Current       | $V_{DS}=-24\text{V}$ , $V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$ |      |       | -1<br>-5  | $\mu\text{A}$    |
| $I_{GSS}$                   | Gate-Body leakage current             | $V_{DS}=0\text{V}$ , $V_{GS}=\pm 12\text{V}$                        |      |       | $\pm 100$ | nA               |
| $V_{GS(th)}$                | Gate Threshold Voltage                | $V_{DS}=V_{GS}$ , $I_D=-250\mu\text{A}$                             | -0.7 | -1    | -1.3      | V                |
| $I_{D(ON)}$                 | On state drain current                | $V_{GS}=-4.5\text{V}$ , $V_{DS}=-5\text{V}$                         | -25  |       |           | A                |
| $R_{DS(ON)}$                | Static Drain-Source On-Resistance     | $V_{GS}=-10\text{V}$ , $I_D=-5\text{A}$<br>$T_J=125^\circ\text{C}$  |      | 42.5  | 49        | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=-4.5\text{V}$ , $I_D=-4\text{A}$                            |      | 54    | 64        | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=-2.5\text{V}$ , $I_D=-1\text{A}$                            |      | 80    | 120       | $\text{m}\Omega$ |
| $g_{FS}$                    | Forward Transconductance              | $V_{DS}=-5\text{V}$ , $I_D=-5\text{A}$                              | 7    | 11    |           | S                |
| $V_{SD}$                    | Diode Forward Voltage                 | $I_S=-1\text{A}$ , $V_{GS}=0\text{V}$                               |      | -0.75 | -1        | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |   |      |       | -3        | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |   |      |       |           |                  |
| $C_{iss}$                   | Input Capacitance                     |   |      | 952   |           | pF               |
| $C_{oss}$                   | Output Capacitance                    | $V_{GS}=0\text{V}$ , $V_{DS}=-15\text{V}$ , $f=1\text{MHz}$         |      | 103   |           | pF               |
| $C_{rss}$                   | Reverse Transfer Capacitance          |   |      | 77    |           | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}$ , $V_{DS}=0\text{V}$ , $f=1\text{MHz}$           |      | 5.9   |           | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |   |      |       |           |                  |
| $Q_g$                       | Total Gate Charge                     |   |      | 9.5   |           | nC               |
| $Q_{gs}$                    | Gate Source Charge                    | $V_{GS}=-4.5\text{V}$ , $V_{DS}=-15\text{V}$ , $I_D=-5\text{A}$     |      | 2     |           | nC               |
| $Q_{gd}$                    | Gate Drain Charge                     |   |      | 3.1   |           | nC               |
| $t_{D(on)}$                 | Turn-On Delay Time                    |   |      | 12    |           | ns               |
| $t_r$                       | Turn-On Rise Time                     | $V_{GS}=-10\text{V}$ , $V_{DS}=-15\text{V}$ , $R_L=3\Omega$ ,       |      | 4     |           | ns               |
| $t_{D(off)}$                | Turn-Off Delay Time                   | $R_{GEN}=6\Omega$   |      | 37    |           | ns               |
| $t_f$                       | Turn-Off Fall Time                    |   |      | 12    |           | ns               |
| $t_{rr}$                    | Body Diode Reverse Recovery Time      | $I_F=-5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                  |      | 21    |           | ns               |
| $Q_{rr}$                    | Body Diode Reverse Recovery Charge    | $I_F=-5\text{A}$ , $dI/dt=100\text{A}/\mu\text{s}$                  |      | 13    |           | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The value in any given application depends on the user's specific board design. The current rating is based on the  $\leq 10\text{s}$  thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C: The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to lead  $R_{\theta JL}$  and lead to ambient.

D: The static characteristics in Figures 1 to 6, 12, 14 are obtained using  $80\mu\text{s}$  pulses, duty cycle 0.5% max.

E: These tests are performed with the device mounted on  $1\text{in}^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

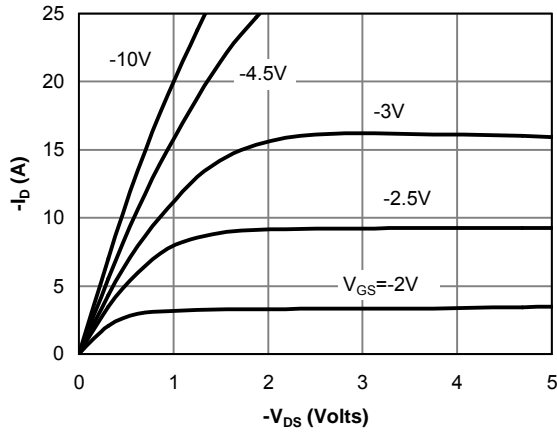


Fig 1: On-Region Characteristics

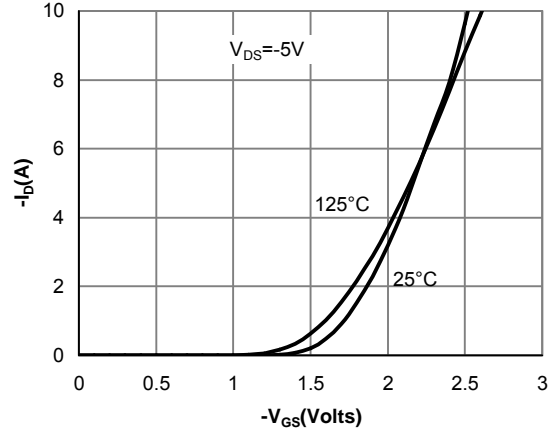


Figure 2: Transfer Characteristics

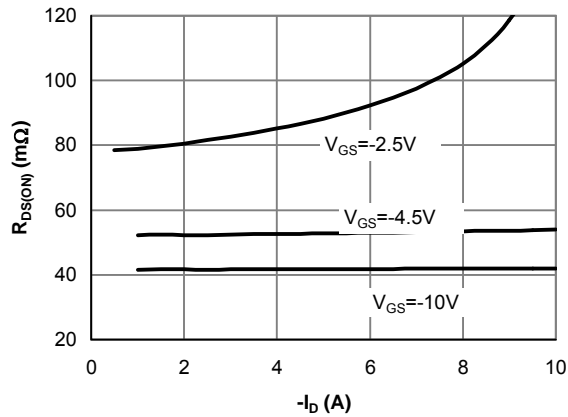


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

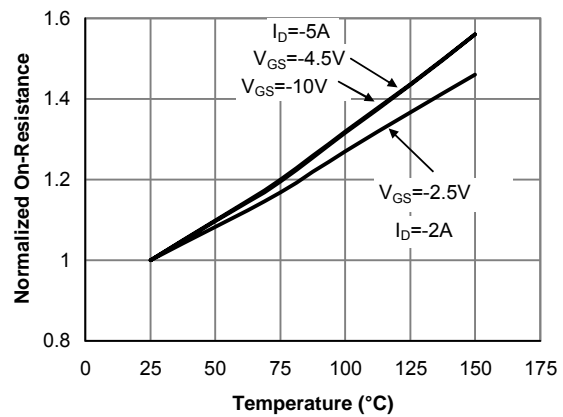


Figure 4: On-Resistance vs. Junction Temperature

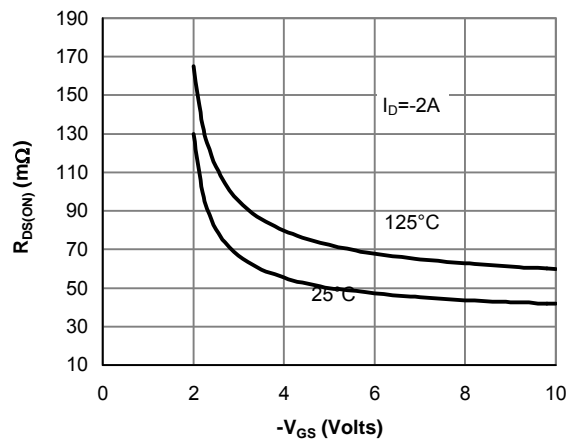


Figure 5: On-Resistance vs. Gate-Source Voltage

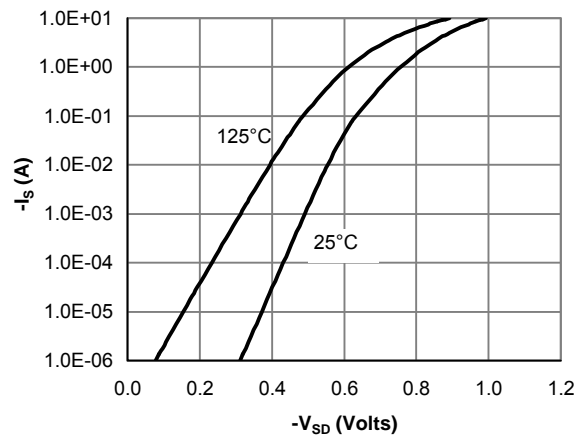


Figure 6: Body-Diode Characteristics

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

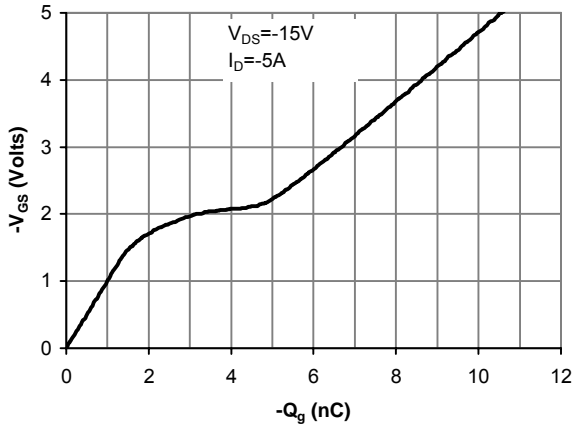


Figure 7: Gate-Charge Characteristics

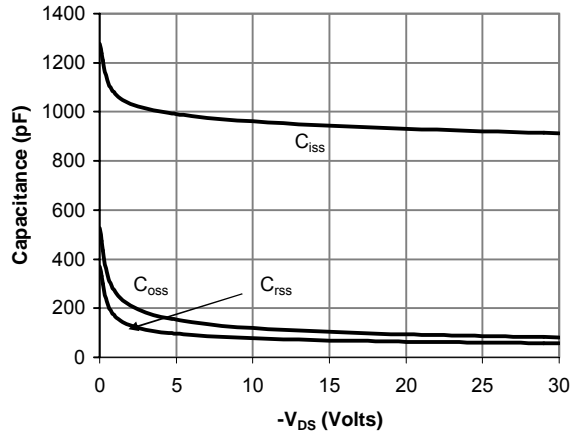


Figure 8: Capacitance Characteristics

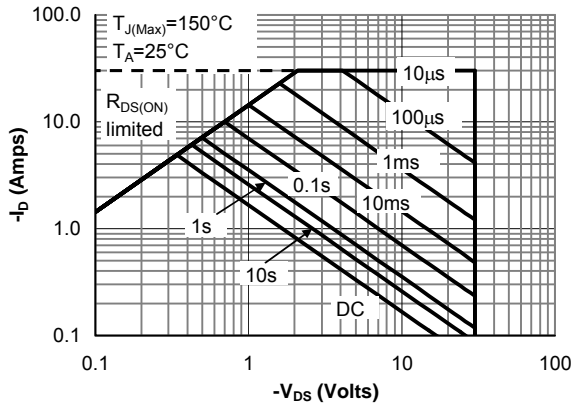


Figure 9: Maximum Forward Biased Safe Operating Area (Note E)

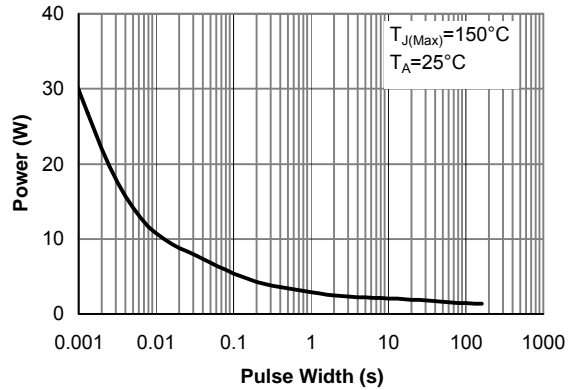


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note E)

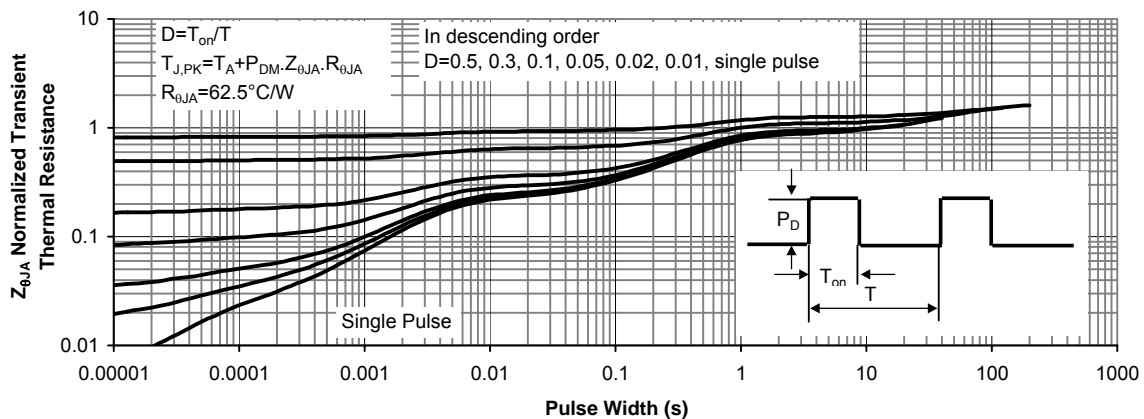


Figure 11: Normalized Maximum Transient Thermal Impedance